

November 1992 Revised January 1999

74ABT574 Octal D-Type Flip-Flop with 3-STATE Outputs

General Description

The ABT574 is an octal flip-flop with a buffered common Clock (CP) and a buffered common Output Enable $(\overline{\text{OE}})$. The information presented to the D inputs is stored in the flip-flops on the LOW-to-HIGH Clock (CP) transition.

The device is functionally identical to the ABT374 but has broadside pinouts.

Features

- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to ABT374

- 3-STATE outputs for bus-oriented applications
- Output sink capability of 64 mA, source capability of 32 mA
- Guaranteed output skew
- Guaranteed multiple output switching specifications
- Output switching specified for both 50 pF and 250 pF loads
- Guaranteed simultaneous switching, noise level and dynamic threshold performance
- Guaranteed latchup protection
- High impedance glitch free bus loading during entire power up and power down cycle
- Non-destructive hot insertion capability

Ordering Code:

Order Number	Package Number	Package Description
74ABT574CSC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
74ABT574CSJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74ABT574CMSA	MSA20	20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide
74ABT574CMTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

Connection Diagram

Pin Assignment for TSSOP, SOIC and SSOP



Pin Descriptions

Pin Names	Description
D ₀ –D ₇	Data Inputs
CP	Clock Pulse Input
	(Active Rising Edge)
ŌĒ	3-STATE Output Enable
	Input (Active LOW)
O ₀ -O ₇	3-STATE Outputs

Functional Description

The ABT574 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-STATE true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH Clock (CP) transition.

With the Output Enable (\overline{OE}) LOW, the contents of the eight flip-flops are available at the outputs. When $\overline{\text{OE}}$ is HIGH, the outputs are in a high impedance state. Operation of the \overline{OE} input does not affect the state of the flipflops.

Function Table

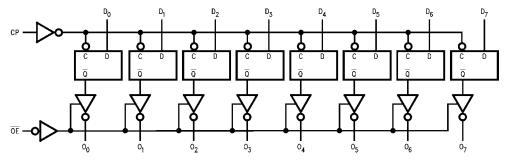
Inputs			Internal	Outputs	Function
OE	СР	D	Q	0	
Н	H or L	L	NC	Z	Hold
Н	H or L	Н	NC	Z	Hold
Н	~	L	L	Z	Load
Н	~	Н	Н	Z	Load
L	~	L	L	L	Data Available
L	~	Н	Н	Н	Data Available
L	H or L	L	NC	NC	No Change in Data
L	H or L	Н	NC	NC	No Change in Data

- H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Immaterial
- Z = High Impedance

 ∠ = LOW-to-HIGH Transition

 NC = No Change

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

Storage Temperature -65°C to +150°C Ambient Temperature under Bias -55°C to +125°C -55°C to +150°C

Junction Temperature under Bias

 $V_{\mbox{\footnotesize CC}}$ Pin Potential to

Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0V

-30 mA to +5.0 mA

Input Current (Note 2)

Voltage Applied to Any Output

in the Disabled or

Power-Off State -0.5V to 5.5V in the HIGH State -0.5V to V_{CC}

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA) DC Latchup Source Current -500 mA Over Voltage Latchup (I/O)

Recommended Operating Conditions

Free Air Ambient Temperature -40°C to +85°C Supply Voltage +4.5V to +5.5V

Minimum Input Edge Rate ($\Delta V/\Delta t$)

Data Input 50 mV/ns **Enable Input** 20 mV/ns Clock Input 100 mV/ns

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation

under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Param	eter	Min	Тур	Max	Units	v _{cc}	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized HIGH Signal
V _{IL}	Input LOW Voltage				8.0	V		Recognized LOW Signal
V _{CD}	Input Clamp Diode Vo	ltage			-1.2	V	Min	I _{IN} = -18 mA
V _{OH}	Output HIGH Voltage		2.5			V	Min	$I_{OH} = -3 \text{ mA}$
			2.0			V	Min	$I_{OH} = -32 \text{ mA}$
V _{OL}	Output LOW Voltage				0.55			I _{OL} = 64 mA
I _{IH}	Input HIGH Current				1	μΑ	Max	V _{IN} = 2.7V (Note 3)
					1			$V_{IN} = V_{CC}$
I _{BVI}	Input HIGH Current Br	eakdown Test			7	μΑ	Max	V _{IN} = 7.0V
I _{IL}	Input LOW Current				-1	μΑ	Max	V _{IN} = 0.5V (Note 3)
					-1			$V_{IN} = 0.0V$
V _{ID}	Input Leakage Test		4.75			V	0.0	$I_{ID} = 1.9 \mu A$
								All Other Pins Grounded
I _{OZH}	Output Leakage Curre	ent			10	μΑ	0 – 5.5V	V _{OUT} = 2.7V; OE = 2.0V
I _{OZL}	Output Leakage Curre	ent			-10	μΑ	0 – 5.5V	$V_{OUT} = 0.5V$; $\overline{OE} = 2.0V$
los	Output Short-Circuit C	urrent	-100		-275	mA	Max	V _{OUT} = 0.0V
I _{CEX}	Output High Leakage	Current			50	μΑ	Max	$V_{OUT} = V_{CC}$
I _{ZZ}	Bus Drainage Test				100	μΑ	0.0	V _{OUT} = 5.5V; All Other GND
I _{CCH}	Power Supply Current				50	μΑ	Max	All Outputs HIGH
I _{CCL}	Power Supply Current				30	mA	Max	All Outputs LOW
I _{CCZ}	Power Supply Current				50	μΑ	Max	OE = V _{CC}
								All Others at V _{CC} or GND
I _{CCT}	Additional I _{CC} /Input	Outputs Enabled			2.5	mA		$V_{I} = V_{CC} - 2.1V$
		Outputs 3-STATE			2.5	mA	Max	Enable Input $V_I = V_{CC} - 2.1V$
		Outputs 3-STATE			2.5	mA		Data Input V _I = V _{CC} - 2.1V
								All Others at V _{CC} or GND
I _{CCD}	Dynamic I _{CC}	No Load				mA/	Max	Outputs Open, $\overline{OE} = GND$,
	(Note 3)				0.30	MHz		One Bit Toggling (Note 4),
								50% Duty Cycle

Note 3: Guaranteed, but not tested.

Note 4: For 8-bit toggling, $I_{CCD} < 0.8 \text{ mA/MHz}.$

DC Electrical Characteristics

(SOIC Package)

Symbol	Parameter	Min	Тур	Max	Units	v _{cc}	Conditions $C_L = 50 \text{ pF}, R_L = 500\Omega$
V _{OLP}	Quiet Output Maximum Dynamic V _{OL}		0.7	1.0	V	5.0	T _A = 25°C (Note 5)
V _{OLV}	Quiet Output Minimum Dynamic V _{OL}	-1.5	-1.1		V	5.0	T _A = 25°C (Note 5)
V _{OHV}	Minimum HIGH Level Dynamic Output Voltage	2.5	3.0		V	5.0	T _A = 25°C (Note 6)
V _{IHD}	Minimum HIGH Level Dynamic Input Voltage	2.0	1.6		V	5.0	T _A = 25°C (Note 7)
V _{ILD}	Maximum LOW Level Dynamic Input Voltage		1.2	0.8	V	5.0	T _A = 25°C (Note 7)

Note 5: Max number of outputs defined as (n). n - 1 data inputs are driven 0V to 3V. One output at LOW. Guaranteed, but not tested.

Note 6: Max number of outputs defined as (n). n - 1 data inputs are driven 0V to 3V. One output HIGH. Guaranteed, but not tested.

Note 7: Max number of data inputs (n) switching. n – 1 inputs switching 0V to 3V. Input-under-test switching: 3V to threshold (V_{ILD}), 0V to threshold (V_{IHD}). Guaranteed, but not tested.

AC Electrical Characteristics

(SOIC and SSOP Package)

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		$T_A = -55^{\circ}\text{C to } +125^{\circ}\text{C}$ $V_{CC} = 4.5\text{V to } 5.5\text{V}$ $C_L = 50 \text{ pF}$		$T_A = -40$ °C to +85°C $V_{CC} = 4.5$ V to 5.5V $C_L = 50$ pF		Units	
		Min	Тур	Max	Min	Max	Min	Max	
f _{max}	Max Clock Frequency	150	200		150		150		MHz
t _{PLH}	Propagation Delay	2.0	3.2	5.0	1.5	7.0	2.0	5.0	ns
t _{PHL}	CP to O _n	2.0	3.3	5.0	1.5	7.4	2.0	5.0	
t _{PZH}	Output Enable Time	1.5	3.1	5.3	1.0	6.5	1.5	5.3	ns
t_{PZL}		1.5	3.1	5.3	1.0	7.2	1.5	5.3	
t _{PHZ}	Output Disable Time	1.5	3.6	5.4	1.0	7.2	1.5	5.4	ns
t_{PLZ}		1.5	3.4	5.4	1.0	6.7	1.5	5.4	

AC Operating Requirements

		$T_A = +25^{\circ}C$		$T_A = -55^{\circ}C$ to $+125^{\circ}C$		T _A = -40°	C to +85°C	
Combal	Parameter	V _{CC} =	$V_{CC} = +5.0V$		V _{CC} = 4.5V to 5.5V		V _{CC} = 4.5V to 5.5V	
Symbol	Symbol Parameter		C _L = 50 pF		$C_L = 50 \text{ pF}$		$C_L = 50 \text{ pF}$	
		Min	Max	Min	Max	Min	Max	
t _S (H)	Setup Time, HIGH	1.0		1.5		1.0		ns
t _S (L)	or LOW D _n to CP	1.5		2.0		1.5		
t _H (H)	Hold Time, HIGH	1.0		2.0		1.0		ns
t _H (L)	or LOW D _n to CP	1.0		2.0		1.0		
t _W (H)	Pulse Width, CP,	3.0		3.3		3.0		ns
t _W (L)	HIGH or LOW	3.0		3.3		3.0		

Extended AC Electrical Characteristics

(SOIC Package)

		$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $V_{CC} = 4.5\text{V to } 5.5\text{V}$ $C_L = 50 \text{ pF}$ 8 Outputs Switching		$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $V_{CC} = 4.5\text{V to } 5.5\text{V}$		$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $V_{CC} = 4.5\text{V to } 5.5\text{V}$		
Symbol	Parameter			C _L = 250 pF (Note 9)		C _L = 250 pF 8 Outputs Switching		Units
		•	te 8)	,	,		e 10)	
		Min	Max	Min	Max	Min	Max	
t _{PLH}	Propagation Delay	1.5	5.7	2.0	7.8	2.0	10.0	ns
t _{PHL}	CP to O _n	1.5	5.7	2.0	7.8	2.0	10.0	
t _{PZH}	Output Enable Time	1.5	6.2	2.0	8.0	2.0	10.5	ns
t _{PZL}		1.5	6.2	2.0	8.0	2.0	10.5	
t _{PHZ}	Output Disable Time	1.0	5.5	(Note	e 11)	(Not	e 11)	ns
t _{PLZ}		1.0	5.5					

Note 8: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase (i.e., all LOW-to-HIGH, HIGH-to-LOW, etc.).

Note 9: This specification is guaranteed but not tested. The limits represent propagation delay with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 10: This specification is guaranteed but not tested. The limits represent propagation delays for all paths described switching in phase (i.e., all LOW-to-HIGH, HIGH-to-LOW, etc.) with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load.

Note 11: The 3-STATE Delay Times are dominated by the RC network (500Ω, 250 pF) on the output and has been excluded from the datasheet.

Skew

(Note 12)

(SOIC package)

(CC.C pao.	inge)	T _A = -40°C to +85°C	T _A = -40°C to +85°C	
		$\mathbf{V_{CC}} = \mathbf{4.5V} \mathbf{-5.5V}$	V _{CC} = 4.5V-5.5V	
Symbol	Parameter	C _L = 50 pF	C _L = 250 pF	Units
•,		8 Outputs Switching	8 Outputs Switching	-
		(Note 12)	(Note 13)	
		Max	Max	
t _{OSHL}	Pin to Pin Skew	1.0	1.8	ns
(Note 14)	HL Transitions			
toslh	Pin to Pin Skew	1.0	1.8	ns
(Note 14)	LH Transitions			
t _{PS}	Duty Cycle	1.8	4.3	ns
(Note 15)	LH-HL Skew			
t _{OST}	Pin to Pin Skew	2.0	4.3	ns
(Note 14)	LH/HL Transitions			
t _{PV}	Device to Device Skew	2.5	4.6	ns
(Note 16)	LH/HL Transitions			

Note 12: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase (i.e., all LOW-to-HIGH, HIGH-to-LOW, etc.).

Note 13: This specification is guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load.

Note 14: Skew is defined as the absolute value of the difference between the actual propagation delays for any two separate outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (toSHL), LOW-to-HIGH (toSLH), or any combination switching LOW-to-HIGH and/or HIGH-to-LOW (toST). This specification is guaranteed but not tested.

Note 15: This describes the difference between the delay of the LOW-to-HIGH and the HIGH-to-LOW transition on the same pin. It is measured across all the outputs (drivers) on the same chip, the worst (largest delta) number is the guaranteed specification. This specification is guaranteed but not tested.

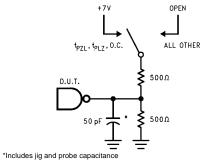
Note 16: Propagation delay variation for a given set of conditions (i.e., temperature and V_{CC}) from device to device. This specification is guaranteed but not tested.

Capacitance

Symbol	Parameter	Тур	Units	Conditions T _A = 25°C
C _{IN}	Input Capacitance	5.0	pF	$V_{CC} = 0V$
C _{OUT} (Note 17)	Output Capacitance	9.0	pF	$V_{CC} = 5.0V$

Note 17: C_{OUT} is measured at frequency f = 1 MHz, per MIL-STD-883B, Method 3012.

AC Loading



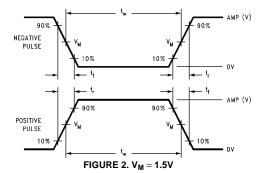


FIGURE 1. Standard AC Test Load

Input Pulse Requirements

Amplitude	Rep. Rate	t _W	t _r	t _f
3.0V	1 MHz	500 ns	2.5 ns	2.5 ns

FIGURE 3. Test Input Signal Requirements

AC Waveforms

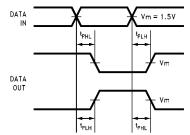


FIGURE 4. Propagation Delay Waveforms for Inverting and Non-Inverting Functions

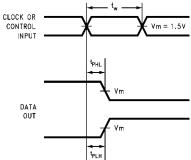


FIGURE 5. Propagation Delay, Pulse Width Waveforms

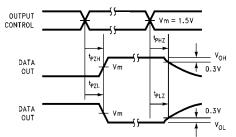


FIGURE 6. 3-STATE Output HIGH and LOW Enable and Disable Times

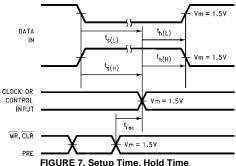
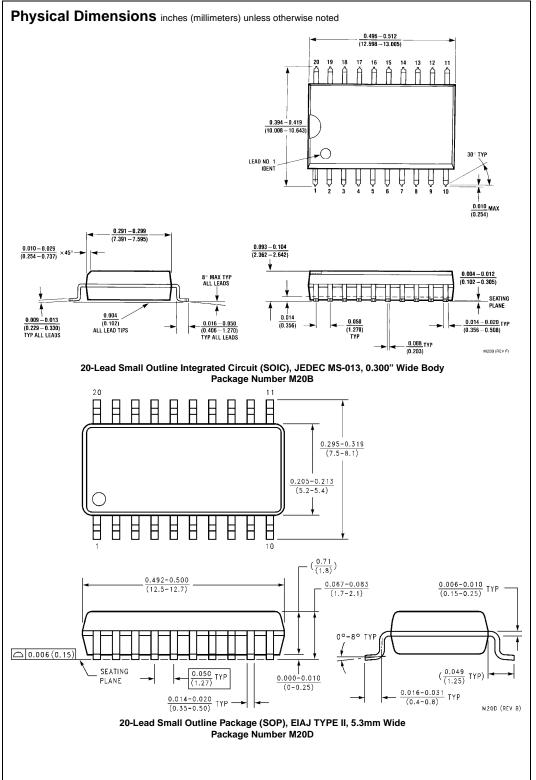
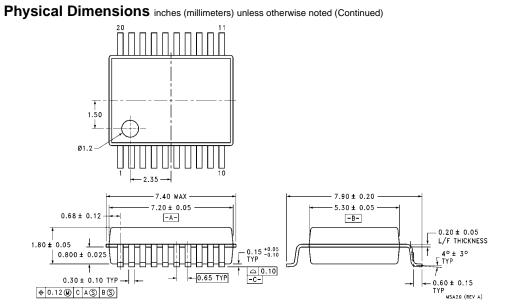


FIGURE 7. Setup Time, Hold Time and Recovery Time Waveforms





20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide Package Number MSA20

Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 6.5±0.1 -0.20 20 4.16 7.72 6,4 4.4±0.1 -B-3,2 0.42 0.65 PIN #1 IDENT. LAND PATTERN RECOMMENDATION O.1 C ALL LEAD TIPS SEE DETAIL A -0.90+0.15 0.09-0.20 0.1±0.05 0.65 0.19-0.30 |+|0.100||A||B||0||0|| -12.00° R0.09min GAGE PLANE DIMENSIONS ARE IN MILLIMETERS 0.25 NOTES: A. CONFORMS TO JEDEC REGISTRATION MD-153, VARIATION AC, REF NOTE 6, DATE 7/93. -0.6±0.1--R0.09mln -1.00 B. DIMENSIONS ARE IN MILLIMETERS. C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLDS FLASH, AND TIE BAR EXTRUSIONS. DETAIL A

20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC20

D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

user.

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